

Title (en)  
PLANAR DIAC

Title (de)  
PLANAR-DIAC

Title (fr)  
DIAC PLANAR

Publication  
**EP 1328980 A1 20030723 (FR)**

Application  
**EP 01976431 A 20011012**

Priority  
• FR 0103179 W 20011012  
• FR 0013180 A 20001013

Abstract (en)  
[origin: FR2815472A1] The diac comprises a substrate (21) of highly doped n-type conductivity, an epitaxial layer (22) of lightly doped p-type conductivity on the side of the upper surface of the epitaxial layer, a channel-restraining ring (25) of p-type conductivity with higher doping level than that of the epitaxial layer and formed at the exterior of the region (24), a peripheral wall (26) of highly doped n-type conductivity at the exterior of the ring (25), extending vertically and joining the substrate, and metallic layers (M1,M2). The channel-restraining ring (25) has the role of suppressing leakage currents flowing in a region below the upper surface of the epitaxial layer (22) from the metallic layer (M1) towards the metallic layer (M2) by the intermediary of peripheral wall (26) and the substrate (21). The region (24) extends to about 5 micrometer from the upper surface of the epitaxial layer, and the set including the region (23) and the layer (22) extends to about 12 micrometer. The diac is asymmetrical, and the breakdown voltages are 32 V and -50 V. A symmetrical diac can be formed by assembling two asymmetrical diacs in antiparallel configuration. The antiparallel assembly comprises the first diac soldered by the rear surface on a conducting plate, the second diac soldered by the rear surface on another conducting plate, and the front surface of each diac soldered by a wire to the conducting plate carrying the other diac.

IPC 1-7  
**H01L 29/861; H01L 25/07**

IPC 8 full level  
**H01L 29/861** (2006.01)

CPC (source: EP US)  
**H01L 29/8611** (2013.01 - EP US); **H01L 29/8618** (2013.01 - EP US)

Citation (search report)  
See references of WO 0231889A1

Designated contracting state (EPC)  
FR GB

DOCDB simple family (publication)  
**FR 2815472 A1 20020419; FR 2815472 B1 20030321; CN 1220275 C 20050921; CN 1470077 A 20040121; EP 1328980 A1 20030723; US 2004012034 A1 20040122; US 7321138 B2 20080122; WO 0231889 A1 20020418**

DOCDB simple family (application)  
**FR 0013180 A 20001013; CN 01817267 A 20011012; EP 01976431 A 20011012; FR 0103179 W 20011012; US 39841903 A 20030407**